

RESEARCH ARTICLE

View Article Online
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Cite this: *Mater. Chem. Front.*,
2024, 8, 3358

Emergence of Ruddlesden–Popper phases and other pitfalls for moderate temperature solution deposited chalcogenide perovskites†

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Chalcogenide perovskites have recently attracted significant attention for renewable energy applications due to their predicted combination of air, moisture, and thermal stability, which has been experimentally validated, along with their excellent optoelectronic properties, which are still under experimental investigation. While historically requiring high synthesis temperatures, some solution-processed routes have recently emerged for synthesizing chalcogenide perovskites, such as BaZrS₃ and BaHfS₃, at temperatures below 600 °C. This study discusses several experimental challenges associated with the moderate-temperature synthesis of solution-deposited chalcogenide perovskites. Firstly, we identify Ruddlesden–Popper (RP) phases as thermodynamically stable competing secondary phases in perovskite synthesis. High sulfur pressures favor the formation of BaZrS₃ or BaHfS₃, whereas lower sulfur pressures result in a mixture of perovskite and RP phases. Additionally, we briefly discuss the mechanism of moderate-temperature synthesis of chalcogenide perovskites, including some of the morphological and optoelectronic challenges it presents, such as grain overgrowth, secondary phase contamination entrapment, and the presence of mid-band gap emissions. Finally, we address the importance of substrate selection and the potential presence of Ca- and Na-based impurities originating from cation out-diffusion from glass substrates. Addressing these challenges will be crucial as these unique materials continue to be investigated for applications in optoelectronic devices.

Received 28th May 2024,
Accepted 18th August 2024

DOI: 10.1039/d4qm00441h

rsc.li/frontiers-materials

Introduction

Chalcogenide perovskites are a promising, non-toxic, and earth-abundant alternative to metal halide perovskites for applications in photovoltaics and many other optoelectronic devices. Similar to metal halide perovskites, II–IV–VI chalcogenide perovskites have an ABX₃ composition where A is an alkaline earth metal, B is a Group 4 transition metal, and X is a chalcogen. BaZrS₃ is the most widely studied of these materials due to its lower synthesis temperatures, thermodynamic favorability, and favorable bandgap for the top layer in a tandem

device.^{1–17} Computational work has suggested that this material and BaHfS₃ have high near-band edge absorption coefficients, good carrier transport, and band gap tunability.^{1–4,18–30} Moreover, chalcogenide perovskites have exhibited superior stability in air, moisture, and thermal conditions compared to their lead halide counterparts.^{31–35} However, most synthesis approaches in the literature for BaZrS₃ and BaHfS₃ utilize solid state or vacuum-deposited approaches, which involve high-temperature sulfurization or annealing steps exceeding 600 °C, making them incompatible with the glass substrates and conductive back contacts required for the synthesis of photovoltaic devices. Therefore, low-temperature synthesis methods are highly desirable for chalcogenide perovskites. One such method is solution processing.

Solution processing of thin film materials is an appealing method to synthesize optoelectronic devices, including photovoltaics, due to its potential for reducing manufacturing costs by allowing for continuous, high throughput, roll-to-roll processing over large areas with high materials utilization. Literature is abundant on utilizing solution-processed methods to

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† Electronic supplementary information (ESI) available. See DOI: <https://doi.org/10.1039/d4qm00441h>

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synthesize thin film photovoltaic materials like the halide perovskites³⁶ and chalcogenide materials including, but not limited to Cu(In,Ga)Se₂ (CIGSe), Cu₂ZnSnSe₄ (CZTSe), Ag₂ZnSnSe₄ (AZTSe).^{37–41} Several robust solvent systems, including the amine-thiol and alkylammonium-polyselenide chemistries, have been shown to dissolve a variety of different late and post-transition metals and their various compounds including Cu, Ag, In, Ga, Sn, Zn, As, Sb, and Bi metals and metal chalcogenides, and the resulting solutions have been used to synthesize various thin-film semiconductor materials including CIGSe, CZTSe, AZTSe, Cu₃AsS₄, and Cd(Se,Te).^{42–49} Hydrazine^{50,51} and DMSO/DMF-Thiourea^{52,53} based synthesis approaches for thin film photovoltaics have also been reported. However, none of the above approaches have yet been observed to successfully dissolve early transition metals, such as Zr, Hf, or their metal-containing species of interest, that would result in a successful synthesis of chalcogenide perovskites.

Recently, a few new routes for lower temperature synthesis of BaZrS₃ have been reported, including a synthesis route by Zilevu *et al.* where metal amide precursors in oleylamine solution were used to create BaZrS₃ nanoparticles at 365 °C,⁵⁴ a route by Yang *et al.* where luminescent nanoparticles were synthesized at 330 °C utilizing barium dibutyldithiocarbamate and zirconium diethyldithiocarbamate,⁵⁵ a mixed phase route reported by Turnley *et al.* where ZrH₂ particles were suspended in a precursor slurry containing barium thiulates which were deposited on a glass substrate and created crystalline BaZrS₃ after a 575 °C sulfurization step,⁵⁶ and a fully solution-deposited route reported by Pradhan *et al.* where barium dithiocarboxylates and zirconium dithiocarbamates were fully dissolved and deposited on a glass substrate before crystalline material was grown after a 575 °C sulfurization step.⁵⁷ Vincent *et al.* also recently demonstrated solution-processing methods that utilize metal sulfides and metal chlorides to synthesize BaZrS₃ at temperatures below 600 °C.⁵⁸ Explaining the low-temperature growth mechanism, Comparotto *et al.*, Yang *et al.*, and Vincent *et al.* have suggested that a liquid barium polysulfide (BaS_x) flux may be playing a pivotal role in synthesizing crystalline BaZrS₃ by overcoming kinetic- or diffusion-related barriers *via* the liquid flux to allow for lower-temperature synthesis methods.^{8,55–57} With the ability to synthesize BaZrS₃, and related chalcogenide perovskites such as BaHfS₃, at lower temperatures, there is reason to be optimistic about the potential of this class of materials. However, many challenges remain, including secondary phase contaminants, oxides, poor or broad photoluminescence (PL), and non-continuous growth of BaZrS₃ films.^{8,55–57} Our experience utilizing molecular precursor inks for synthesizing BaZrS₃ also highlights several challenges in working with chalcogenide perovskites that have sparsely been mentioned in the literature.

In this paper, we outline several experimental challenges, offer insights on addressing some of these challenges, and identify areas that necessitate further attention from the broader research community. Initially, we investigate the influence of the partial pressure of elemental sulfur on the formation of BaZrS₃ and related secondary phases during the moderate-temperature

sulfurization heat treatment step. Subsequently, we examine the challenges associated with achieving rapid, low-temperature growth of large BaZrS₃ grains. Following this, we explore challenges related to photoluminescence (PL) and secondary phases exhibiting PL emissions near the band gap of chalcogenide perovskites. Finally, we demonstrate how sulfurization conditions affect substrates utilized in synthesizing chalcogenide perovskites and provide recommendations for advancing research in this field. Our findings can serve as a roadmap for researchers investigating chalcogenide perovskites.

Results and discussion

Impact of sulfur partial pressure during sulfurization heat treatment

The solution-processing of BaZrS₃ films from molecular precursor inks, thus far, has shown promise yet presents several challenges. Unlike the solution-processed synthesis of other chalcogenides, such as Cu(In,Ga)(S,Se)₂, BaZrS₃ does not nucleate after annealing the as-coated molecular precursor film on the hotplate in an inert glovebox atmosphere. Instead, it forms an amorphous matrix of Ba–Zr–S, requiring subsequent moderate-temperature annealing of the film in the presence of sulfur. The precise cause of this challenge in direct-to-film nucleation of BaZrS₃ is not entirely clear, but several factors may contribute to it. One possibility is the absence of a liquid medium on the film at the nucleation temperature, which could restrict the mobility of elements and impede nucleation. Alternatively, a sulfur-deficient environment during annealing on the hotplate may affect the kinetics of BaZrS₃ nucleation. Additionally, zirconium's strong affinity for oxygen may result in small amounts of oxygen impurities in the inert atmosphere inhibiting nucleation. Another factor could be excessive residual carbon in the film, which is known to impact nucleation and grain growth.⁶¹ Some challenges discussed in this study stem from the inability to nucleate the ternary compound after hotplate annealing and the reliance on a liquid medium during subsequent heat treatment. Hence, developing soluble precursors capable of decomposition followed by subsequent nucleation under suitable annealing conditions without the need for an external sulfur atmosphere while maintaining a constant Ba/Zr ratio is crucial.

As reported in previous work, BaZrS₃ and BaHfS₃ can be synthesized using barium dithiocarboxylates and group IV metal dithiocarbamate precursors dissolved in a pyridine-based ink.⁵⁷ These precursors are synthesized through well-established CS₂ insertion chemistry routes^{62–64} utilizing bis(pentamethylcyclopentadienyl)barium(II) (Cp*₂Ba) and tetrakis(ethylmethylamino)zirconium(IV) (TEMAZ) or tetrakis(ethylmethylamino)hafnium(IV) (TEMAH). The resulting inks were blade coated onto low-alkali Eagle XG (EXG) glass or quartz substrates with hotplate annealing at 200 °C between each coated layer in an inert nitrogen atmosphere to create a film. However, the film was amorphous at this stage, showing no distinct peaks in Raman spectroscopy or powder X-ray diffraction (XRD).⁵⁷ It should be noted that these measurements were performed in air where the precursor film may have



degraded into related oxide-containing phases, obscuring accurate representation of the film before removal from the inert atmosphere. Nonetheless, to nucleate crystalline chalcogenide perovskites at temperatures of 575 °C, we found that an external sulfur source was required, and sulfurization heat treatment was accomplished by sealing the film in an evacuated ampule alongside sulfur and HfH₂ powder. Due to the high oxophilicity of transition metals such as Zr and Hf, even trace quantities of oxygen in the system can limit the formation of crystalline chalcogenide perovskites and even form metal oxides such as ZrO₂ and BaZrO₃. This demonstrates the need for a system that preferentially traps O₂ from the reaction environment and the film. For this case, the HfH₂ acts as an oxygen sink for any residual oxygen present in the film or the ampule, forming HfO₂, due to the thermodynamic driving force caused by hafnium's higher oxophilicity than zirconium. Later work studying the mechanism of the HfH₂ oxygen sink showed that in the presence of a sulfur atmosphere, HfH₂ reacts with sulfur to form HfS₃ and H₂S.⁶⁵ The H₂S can then react with oxides in the ampule or the film, forming H₂O. This H₂O is then shuttled back to the HfS₃, forming HfO₂ and regenerating H₂S. Changing the ratio of sulfur to HfH₂ in the ampules during sulfurization makes it possible to control how much sulfur is entrapped as HfS₃ and control the partial pressure of sulfur and H₂S in the ampule. However, the coexistence of H₂S and sulfur within the ampule environment complicates the independent control of each and the delineation of their individual effects on ternary perovskite synthesis.

The examples in the literature show that sulfur partial pressure can significantly affect the formation rate of BaZrS₃ and whether secondary phases form.^{7,16,59} Wang *et al.* found that the presence of intermediate amounts of excess sulfur allowed for the formation of BaZrS₃ at lower temperatures.⁷ Based on this, Sopiha *et al.* suggested that an ideal sulfur pressure exists under which BaZrS₃ can form quickly, with excess sulfur leading to the formation of ZrS₃ and BaS₃ and too little sulfur resulting in the formation of ZrS₂ and BaS₂.¹⁶ Vincent *et al.* further explored this mechanism and found that while increasing sulfur leads to increasingly more crystalline BaZrS₃ up to the highest sulfur (S₆) partial pressure tested (0.74 bar), no formation of binary sulfides was reported.⁵³ Kayastha *et al.* additionally computed that BaZrS₃ cannot decompose into binaries at any temperature ranging from 230 °C to 1000 °C under sulfur pressures up to 1 × 10⁷ Pa.⁶⁶ Therefore, there is a considerably high sulfur pressure threshold preventing the breakdown of BaZrS₃. However, no information has been documented regarding the lower limit of sulfur pressure required for the synthesis of BaZrS₃.

Using a different synthesis route for the annealed film utilizing BaS and TEMAZ precursors, as described for Method 1 in the experimental section, along with increase in crystallinity, the partial pressure of sulfur plays a large role in the species and secondary phases that form after sulfurization heat treatment. Table 1 shows the initial amount of sulfur and HfH₂ powder loaded into each 5 mL ampule along with the expected H₂S and sulfur partial pressures, assuming that all free sulfur in the ampule is in the S₆ allotrope. While we expect sulfur to be in a mixture of S₈, S₇, and S₆ allotropes,⁶⁷ S₆ was used to determine an upper bound in pressure. Table S1 (ESI†) shows calculated mmol of H₂S, HfS₃, sulfur, H₂, HfS₂, and HfH₂ in the ampules. We assumed that in the presence of excess sulfur, HfH₂ will react to form HfS₃ and H₂S. If sulfur is not in excess, we expect the sulfur to preferentially react with Hf to form HfS₃ or HfS₂ at equilibrium before any excess reacts with H₂ to form H₂S as is described for ZrS₂ and ZrS₃ in previous work.⁶⁵ Note that these calculations do not account for the sulfur consumed or evolved from the film.

It is important to note that while the inks were synthesized with stoichiometric amounts of barium and zirconium, there was a relative loss of zirconium during the hot plate annealing and/or sulfurization step as indicated by X-ray fluorescence (XRF) measurements in Table S2 (ESI†), resulting in Ba-rich films. This phenomenon is the opposite of what is observed when Cp*₂Ba is used as the Ba source, as described in previous work where the relative loss of Ba was more significant, and the Ba/Zr ratio was found to decrease during the annealing and sulfurization steps.⁵⁷ This presents yet another challenge in controlling the Ba/Zr ratio in the film while using dithiocarboxylate and dithiocarbamate precursors.

Fig. 1 shows the different species that form upon a one-hour sulfurization heat treatment at 575 °C for varying levels of sulfur in the ampule. Fig. 1a shows that for S₆ partial pressures of 0.8 atm (Sample 1) and 0.4 atm (Sample 2), we form crystalline BaZrS₃ with no prominent crystalline secondary phases observed. This result is noteworthy as there is a significant excess of Ba and S in Samples 1 and 2, as observed by XRF (Table S2, ESI†). This excess Ba and S is likely in the form of amorphous barium polysulfide. Fig. 1b shows that further reducing the S₆ partial pressure to 0.1 atm (Sample 3) results in the formation of a mixture of BaZrS₃ and Ruddlesden-Popper (RP) phases, Ba₄Zr₃S₁₀ and Ba₃Zr₂S₇, with small amounts of BaS. RP phases in the Ba–Zr–S system consist of a layer of BaS separated by *n* layers of BaZrS₃ perovskite, resulting in a Ba_{*n*+1}Zr_{*n*}S_{3*n*+1} composition where the *n* = 2 and *n* = 3 phases

Table 1 The calculated partial pressure of sulfur (S₆) and H₂S in each ampule based on the initial amount of sulfur and HfH₂ loaded into each ampule. At especially low amounts of sulfur loading, all sulfur reacts with HfH₂ to form HfS₂ or HfS₃, resulting in no sulfur vapor or H₂S in the gaseous phase

Sample	Initial sulfur in ampule (mmol)	Initial HfH ₂ in ampule (mmol)	Theoretical sulfur (S ₆) partial pressure at 575 °C (atm)	Theoretical H ₂ S partial pressure at 575 °C (atm)
1	0.45	0.03	0.8	0.42
2	0.30	0.03	0.4	0.42
3	0.15	0.03	0.1	0.42
4	0.06	0.03	0.0	0.00
5	0.03	0.03	0.0	0.00



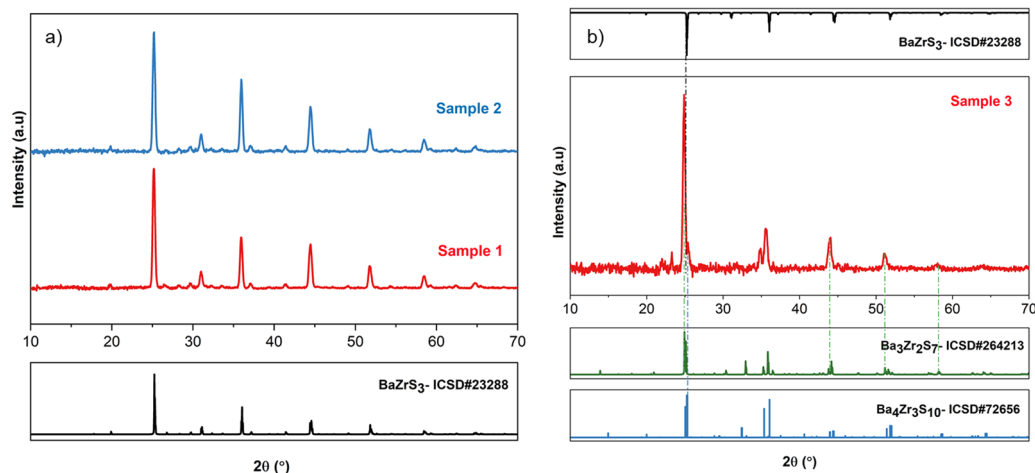


Fig. 1 XRD patterns of Ba–Zr–S films synthesized as described in Method 1 followed by 1 h sulfurization heat treatments at 575 °C in evacuated 5 mL ampules containing 0.03 mmol HfH_2 and (a) 0.45 mmol sulfur in Sample 1 and 0.30 mmol in Sample 2 or (b) 0.15 mmol sulfur in Sample 3. Fig. S2 (ESI†) shows Rietveld refinement for Samples 1 and 3.

are believed to be the most stable.⁶⁸ However, Kayastha *et al.* also reported the presence of impurities of $\text{Ba}_4\text{Zr}_3\text{S}_{10}$ in their solid-state attempts to synthesize BaZrS_3 .⁶⁹ This underscores the importance of reevaluating the relative thermodynamic stabilities of Ba–Zr–S RP phases. Remarkably, RP phases in chalcogenide perovskites exhibit narrower bandgaps than their parent distorted perovskite phase, rendering them suitable as absorber materials for single-junction solar cells.¹⁶ However, their presence as impurity phases alongside BaZrS_3 could pose a challenge.

There is a lack of concrete previous studies that report the effect of low partial pressure of sulfur during the synthesis. However, it plays a decisive role in determining whether RP phases form or crystalline BaZrS_3 forms without detectable crystalline secondary phases. We hypothesize that a liquid barium polysulfide flux forms under sulfur-rich conditions, reducing the kinetic barriers and facilitating the nucleation and growth of ternary Ba–Zr–S material. Upon cooling at roughly 14 °C min^{-1} , this liquid flux is quenched into an amorphous barium polysulfide, which is not detectable in XRD or Raman analyses. Vincent *et al.* have presented scanning electron microscopy (SEM) evidence of the quenching of this liquid barium polysulfide phase under similar cooling conditions.⁵⁹ Under large excesses of sulfur, excessive amounts

of barium polysulfide may form, reducing the kinetic barrier and allowing the thermodynamically favored phase of BaZrS_3 to form under these temperature-pressure conditions, along with amorphous barium polysulfide. However, as the partial pressure of sulfur is reduced, the driving force for the formation of barium polysulfide decreases, and the mass transfer barrier leads to a mixture of the thermodynamically favored phase of BaZrS_3 and RP phases, as evidenced by Sample 3 through XRD patterns (Fig. 1b) and Raman spectra (Fig. S1, ESI†). Rietveld refinement for Samples 1 and 3 is depicted in Fig. S2 (ESI†). The XRD patterns of Sample 1 were fully accounted for by BaZrS_3 , with any other ternary or binary phases tested contributing less than 0.5% to the data. As expected, Sample 3 consisted of a mixture of BaZrS_3 and RP phases, including $\text{Ba}_3\text{Zr}_2\text{S}_7$ and $\text{Ba}_4\text{Zr}_3\text{S}_{10}$. It has been reported that the formation energies of BaZrS_3 and its RP phase counterparts are similar at high temperatures. Kayastha *et al.* mentioned that mixtures of BaZrS_3 and RP phases can form when dwelling at 900 °C in for multiple days.⁶⁹ It is also plausible that RP phases are thermodynamically more stable than BaZrS_3 under sulfur-poor conditions, and localized variations in the films may have rendered conditions suitable for BaZrS_3 despite an otherwise preferred RP phase.

To ensure that these observations are not specific to a particular method, similar experiments were conducted under

Table 2 The following samples are synthesized from hybrid molecular precursor inks comprising Cp^*_2Ba , nanopowder of ZrH_2 , 2-methyl-2-propanethiol, and butylamine. The 50 μL ink containing 0.016 mmoles of ZrH_2 was drop-cast once on a glass substrate. The calculated partial pressure of sulfur (S_6) and H_2S in each ampule is based on the initial amount of sulfur in each ampule and assuming sulfur will react with ZrH_2 to form ZrS_2 and generate H_2S (if enough sulfur is there)

Sample	Ba:Zr ratio in the ink	Initial sulfur in ampule (mmol)	Theoretical sulfur (S_6) partial pressure at 575 °C (atm)	Theoretical H_2S partial pressure at 575 °C (atm)	Sulfurization time
6	1:1	0.31	0.61	0.22	15 min
7	1:1	0.08	0.07	0.22	15 min
8	1:1	0.05	0.03	0.00	15 min
9	1:1	0.08	0.07	0.22	24 h
10	1.5:1	0.08	0.07	0.22	15 min



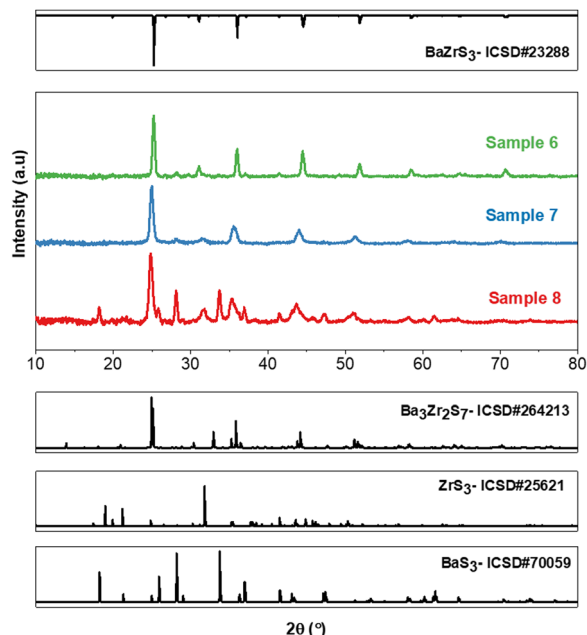


Fig. 2 XRD patterns of Ba–Zr–S films synthesized as described in Method 2 followed by 15 min sulfurization heat treatments at 575 °C in evacuated 5 mL ampules containing varying amounts of sulfur 0.31 mmol sulfur in Sample 6, 0.08 mmol in Sample 7 and 0.05 mmol in Sample 8. Fig. S3–S5 (ESI†) show Rietveld refinement for Samples 6, 7 and 8.

varying sulfur pressures and with different Ba:Zr ratios using the hybrid precursor ink (Method 2) previously reported by our group (see Table 2 for description).⁵¹ Please note that, unlike Method 1, this method does not employ an HfH₂ oxygen trap. Instead, the *in-situ* H₂S produced in this case originates from the zirconium precursor used, ZrH₂. As depicted in Fig. 2 and Fig. S3 (ESI†), stoichiometric films synthesized at low sulfur pressures exhibited mixed phases of BaZrS₃ and Ba₃Zr₂S₇, along with some impurities of BaS₃ and ZrS₃—formation of these binaries appearing to contradict previous statements regarding the trisulfide formation only at higher pressures. The Rietveld refinement in Fig. S4 and S5 (ESI†) shows a significant fraction of Ba₃Zr₂S₇ in the films. Conversely, phase-pure BaZrS₃ was attained at high sulfur pressures for films synthesized from stoichiometric Ba:Zr inks, as shown in Fig. 2 and Fig. S6 (ESI†). In another significant experiment, we sulfurized the as-deposited film at 575 °C for 24 h under sulfur-poor conditions (Sample 9) and observed a significantly higher percentage of Ba₃Zr₂S₇ in the film relative to BaZrS₃, as determined by the Rietveld refinement (see Fig. S7–S9, ESI†). Additionally, we observed that using a solution with a Ba:Zr ratio of 1.5:1 also resulted in a mixture of BaZrS₃, Ba₃Zr₂S₇, and BaS₃ when synthesized under sulfur-poor conditions, illustrated in Fig. S10–S12 (ESI†) for Sample 10.

This underscores that the bulk Ba:Zr ratio and sulfurization time do not significantly influence the synthesis of competing RP phases, with sulfur pressure playing a more decisive role. Furthermore, the synthesis of RP phases does not appear to be specific to the synthesis method. Nevertheless, the potential to synthesize RP phases at 575 °C in as little as 15 minutes could

also be seen as an exciting step towards producing phase-pure RP phases for applications in single-junction solar cells. However, further investigation is necessary to determine the conditions for their phase-pure synthesis at low-to-moderate temperatures. It is also crucial to determine whether small, localized impurities of RP phases consistently exist in bulk BaZrS₃ films produced under high sulfur conditions. Until now, it has been assumed that BaZrS₃ is the thermodynamically favored phase at low temperatures, but competing RP phases now challenge this belief. Similar observations were made for the Ba–Hf–S system using Ba:Hf ratios of 1.5:1 in the ink, as evidenced in Fig. S13 and S14 (ESI†), and should also be a focus of future studies.

Further decreasing the amount of sulfur in the ampules, as shown in Samples 4 and 5 (synthesized using Method 1), results in all the sulfur being consumed by the HfH₂ and forming HfS₂, and consequently, no sulfur vapor is expected to be present at equilibrium in both samples (Table S1, ESI†). It is also possible that HfH₂ may be extracting sulfur from the annealed films themselves. Without sulfur vapor, a liquid barium polysulfide flux cannot form, and consequently, ternary BaZrS₃ or RP phases cannot form in a short duration of a few minutes at 575 °C (see Fig. S15, ESI†). Instead, a mixture of BaS and BaS₃ is observed. It is important to note that while a crystalline zirconium-containing phase is not observed in XRD, XRF measurements (Table S2, ESI†) do show the presence of zirconium in the film, indicating that the zirconium is in an amorphous phase. The strength of the XRD signal is a qualitative indicator of the abundance of each type of crystalline material. As indicated by the lower signal-to-noise ratio for Sample 5 in Fig. S15 (ESI†), the signal from Sample 5 is weaker than that of the other films, meaning there is a lower abundance of crystalline BaS and BaS₃ present. The lower amount of BaS and BaS₃ in Sample 5 compared with Sample 4 demonstrates that the small amount of sulfur present from the coated barium and zirconium dithiocarbamate complexes is not enough to convert the amorphous material into crystalline binary barium sulfides fully and the small amount of sulfur vapor present in the initial stages of sulfurization in Sample 4, before the HfH₂ consumes it, aids in the crystallization of BaS and BaS₃.

We have demonstrated that the partial pressure of sulfur in the ampule plays an essential role in which Ba–Zr–S phase forms after heat treatment. Sulfur present in the dithiocarbamate and dithiocarboxylate precursors alone does not result in the formation of crystalline ternary phase Ba–Zr–S material at temperatures below 600 °C without introducing an external sulfur source. Using sulfur partial pressures of 0.1 atm or lower for Ba–Zr–S films leads to Ruddlesden–Popper phases (Ba₃Zr₂S₇) and binary sulfides such as BaS and BaS₃. However, greater sulfur partial pressures approaching 0.4 atm drive Ba–Zr–S films toward the distorted perovskite phase, even in excess barium.

Impacts of rapid growth on the properties of chalcogenide perovskite grains

While the formation of chalcogenide perovskites, such as BaZrS₃ and BaHfS₃, at low temperatures with the assistance of a barium polysulfide flux, as demonstrated by Vincent *et al.*



and Yang *et al.*,^{59,60} has allowed for the creation of large crystalline grains of perovskite material at moderate temperatures, the perceived fast growth of these grains has led to some significant challenges. Prior work in our group has demonstrated that large micron-sized grains of BaZrS₃ and BaHfS₃ can be synthesized at 575 °C in the presence of a sulfur atmosphere in heat treatment times as short as 10 minutes (excluding a ~10-minute heat up).^{56,57} While rapid grain growth is typically advantageous for the synthesis of thin films, rapid grain growth in our work has led to defective and impure materials with regions of entrapped oxides and secondary phases. Furthermore, this uncontrolled grain growth has also resulted in forming isolated islands of material instead of a continuous film layer after sulfurization heat treatments, making these films unviable for use in renewable energy devices such as photovoltaics. Fig. S16 (ESI†) shows that within 10 minutes at 575 °C, cubic BaZrS₃ grains on the order of 10 μm by 10 μm form from the suspension precursor solution of Method 3. Longer sulfurization times result in cubic BaZrS₃ grains as large as 40 μm per edge, likely due to Ostwald ripening. As BaZrS₃ thin film absorber materials would ideally be less than 1 μm thick, due to its anticipated high absorption coefficient, 10 μm grains are already far too large. The primary challenge with this synthesis approach is that BaZrS₃ does not form in a phase pure manner below ~550 °C due to diffusion limitations aided by the barium polysulfide liquid flux,⁵⁹ but once these crystals of ternary phase chalcogenide perovskites do nucleate, they appear to grow rapidly, absorbing material around the crystals and leading to island growth and thus, non-continuous films. So far, attempts to uniformly nucleate BaZrS₃ or BaHfS₃ and grow dense, ≤1 μm-thick films utilizing a solution-deposited approach have been unsuccessful.

In addition to the problems regarding film homogeneity, the rapid grain growth resulting from the barium polysulfide flux may also lead to a defective material with poor optoelectronic properties and regions of entrapped secondary phases. Fig. 3a shows a bright field transmission electron microscope (TEM) image of a thin lamella of a BaZrS₃ grain prepared using a gallium-focused ion beam (FIB). This sample was synthesized as described in Method 3 and sulfurized for 16 h at 575 °C in a 5 mL borosilicate ampule with 0.1 mmol sulfur without HfH₂. This would result in an estimated S₆ partial pressure of 0.26 atm in the ampule at 575 °C. The TEM image shows many planar defects, including what appears to be many edge dislocations and internal grain boundaries. Furthermore, oxide impurities in the crystal can be identified as bright spots in the image. Fig. 3b is a high-angle annular dark field (HAADF)-scanning transmission electron microscopy (STEM) image of one of these bright spots from the bright field TEM image. Energy dispersive X-ray (EDX) analysis was carried out on this spot and is shown in Fig. 3c–f. We found that these dark regions in the HAADF image are oxygen-rich and poor in sulfur and barium, indicating the presence of a zirconium oxide secondary phase. Comparable Zr–O-rich regions were identified in the films synthesized using Method 4, reported earlier by our group,⁵⁹ followed by sulfurization at 575 °C with sulfur in the presence of HfH₂ (see Fig. S17, ESI†). The slower kinetics of oxygen transport to Hf compared to Zr, coupled with the faster kinetics of BaZrS₃ growth in the presence of BaS_x liquid flux, could possibly be resulting in the entrapment of oxide impurities within the crystal. Thus, it is necessary to further explore and optimize the sulfurization step.

In addition to the poor morphological properties of the synthesized BaZrS₃ grains, the optoelectronic properties of

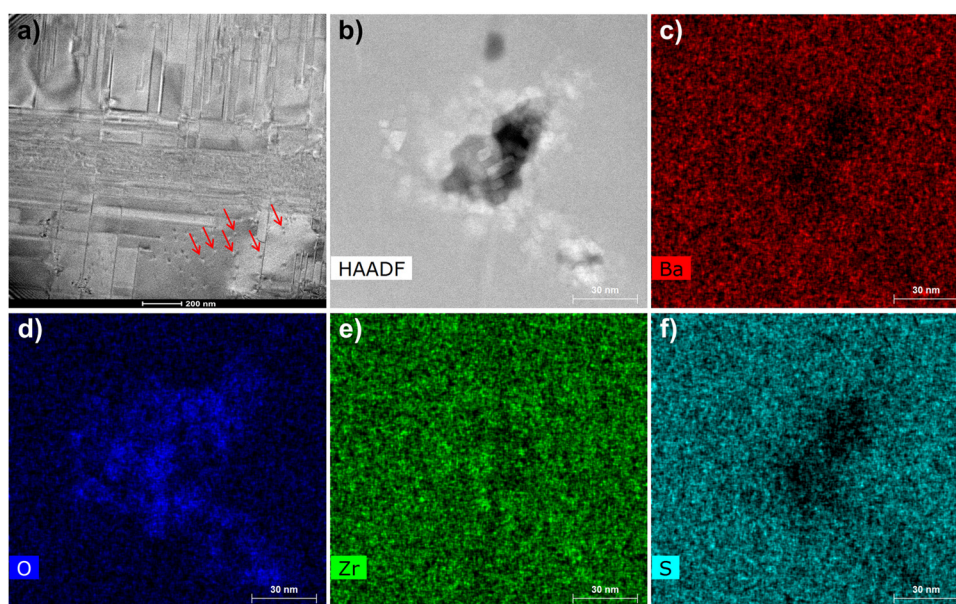


Fig. 3 (a) TEM bright field image of a thin lamella prepared by FIB shows many planar defects and impurities in the grain. The red arrows point out examples of bright spots-indicating oxide impurities- in the image, one of which is analyzed using HAADF-STEM. (b) a HAADF-STEM image of a bright spot seen in the TEM bright field image. (c)–(f) EDX intensity maps of the HAADF image indicate the presence of zirconium oxide embedded in the BaZrS₃ grain.



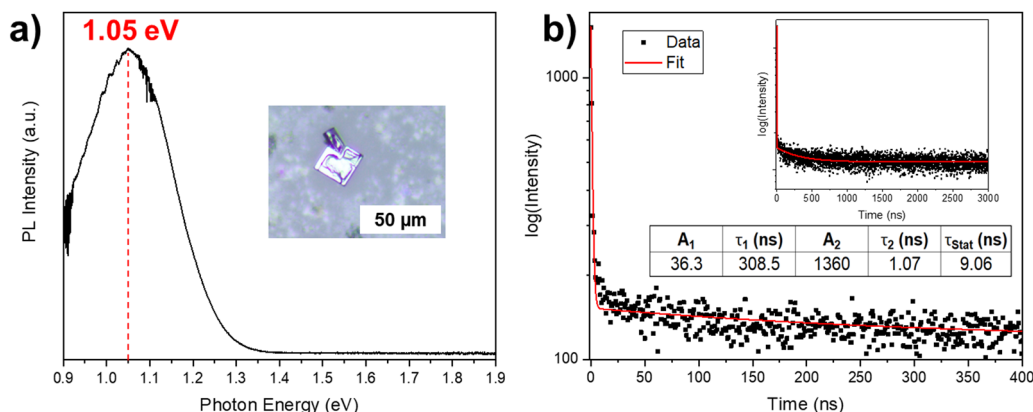


Fig. 4 (a) Photoluminescence (PL) spectrum of a Ba–Zr–S sample synthesized as described in Method 3 on a quartz substrate and sulfurized for 24 h in a 5 mL ampule containing 0.3 mmol sulfur and 0.03 mmol HfH_2 and measured using a 632 nm excitation source. A strong photoemission is observed at 1.05 eV but no band-to-band emission was observed. (b) Time-resolved photoluminescence (TRPL) measurements of the grains in the BaZrS_3 film show a biexponential decay curve with fast decay resulting in carrier lifetimes of 1.1 ns and a long decay resulting in carrier lifetimes of 309 ns. TRPL data show a statistical average minority carrier lifetime of 9.06 ns ($\tau_{\text{stat}} = (A_1\tau_1 + A_2\tau_2)/(A_1 + A_2)$).

these materials are also poor. BaZrS_3 is expected to have a band gap of 1.7 to 1.9 eV,¹⁶ but as shown in Fig. 4a, we observed photoemission at 1.05 eV with no emission near the bandgap. This result was surprising given that multiple computational studies have predicted BaZrS_3 to have excellent optoelectronic properties.^{70,71} Raman analysis ensured the samples measured were BaZrS_3 and did not contain RP secondary phases. The mid-bandgap emission at 1.05 eV is consistently observed in BaZrS_3 synthesized through all solution-based methods documented in this paper. As depicted in Fig. S18 (ESI[†]), it was also detected in solid-state BaZrS_3 samples synthesized using liquid BaS_x flux and I_2 transport agents. This underscores that the mid-gap emission seem to be a common problem across a range of synthesis techniques. Additionally, the peak persists even with prolonged sulfurization times. Márquez *et al.* also observed mid-gap photoluminescence (PL) peaks at 1.14 and 1.35 eV for BaZrS_3 samples sulfurized at temperatures above 1000 °C and attributed them to deep defect states.¹² The 1.05 eV photoemission we observe is likely similar due to the material's deep transition state. Wu *et al.* have recently published computational work on defect tolerance in BaZrS_3 , which suggests that under moderate sulfur conditions, the shallow V_S donor defect is the dominant defect in BaZrS_3 .⁷² The only deep-level defects in BaZrS_3 are Ba_{Zr} , V_{Zr} , S_i , S_{Ba} , and S_{Zr} .⁷² Ba_{Zr} and S_{Zr} are deep acceptors positioned 0.46 eV and 0.40 eV above the valence band maximum (VBM) respectively while V_{Zr} , S_i , and S_{Ba} are deep acceptors positioned 1.28, 1.34, and 1.40 eV below the conduction band minimum (CBM) respectively.⁷² While all deep-level defects have been estimated to have high formation energies under moderate sulfur conditions, S_i , S_{Ba} , and V_{Zr} become the dominant defects under sulfur-rich conditions. In this paper and previous work,⁵⁹ we have demonstrated that low-temperature synthesis of crystalline BaZrS_3 requires excess sulfur, but this approach may increase concentrations of harmful defects such as S_i , S_{Ba} , and V_{Zr} . Additionally, RP phases are known to have band gaps in the region of ~ 1.2 eV, and the presence of local nano-

domains of RP phases in the final films cannot be completely ruled out at this stage. It is noteworthy that samples 7–10, which contain a significant amount of RP phases, also exhibit these emission peaks, albeit at slightly shifted energies. Sample 9, which includes the highest proportion of RP phases relative to BaZrS_3 , also displays a similar peak at 1.15 eV, noticeably shifted from the reported bandgaps of the RP phases in the Ba–Zr–S system (illustrated in Fig. S19, ESI[†]). This emission may originate from near-bandgap states of RP phases trapped within the bulk BaZrS_3 crystals. These harmful defects, or nano-domains of RP phases, may explain the weak band gap photoluminescence in BaZrS_3 and the defect-related photoemission at 1.05 eV.

Owing to the high light absorption coefficient of BaZrS_3 , photons across various wavelengths with energies greater than the bandgap are absorbed thoroughly within the first 200 nm of the film. The near-surface region of the micron-thick film may be suboptimal, resulting in weak band-to-band photoemission and necessitating substantial enhancement. Some of the impurities could potentially include ZrO_x and BaSO_4 , as highlighted by Mukherjee *et al.* using X-ray photoelectron spectroscopy (XPS) measurements.⁷³ The defective grains observed in Fig. 3a and the poor optoelectronic properties of the synthesized materials suggest that significant enhancements in sulfurization conditions are necessary. Additionally, exploring the possibility of etching away the few nanometers from near the top surface of the film could address some of these issues.

Time-resolved photoluminescence spectroscopy (TRPL) shown in Fig. 4b indicates that photogenerated minority carriers in BaZrS_3 have relatively long lifetimes calculated *via* a biexponential decay. A fast decay with a lifetime of 1.1 ns and a slower decay with a lifetime of 309 ns were determined *via* curve fitting, resulting in a statistical average minority carrier lifetime of 9.06 ns. BaZrS_3 synthesized using other approaches and on different substrates, such as low-alkali EXG, also showed these long carrier lifetimes. This lifetime is unexpectedly large for a defective material, which may suggest that



minority carrier trapping/de-trapping is occurring. In this case, some photogenerated minority carriers may be trapped in localized shallow states with capture times similar to the fast decay lifetime of 1.1 ns we observe. The trap emission time could govern the longer decay time of 309 ns.⁷⁴ Voltage-dependent and intensity-dependent TRPL would need to be carried out to confirm this hypothesis as described in Hages *et al.*⁷⁴

Optoelectronic properties of secondary phases and substrate selection

Investigations of chalcogenide perovskites' photoluminescence properties are further complicated by secondary phases that can have PL emissions at the same energy as the related perovskites. These secondary phases likely contributed to emissions observed in photoluminescent grains in our previous studies.^{56,57} Fig. 5a shows a PL image of a grain that showed luminescence centered at 1.72 eV in a Ba–Zr–S film synthesized as described in Method 3 on EXG glass and sulfurized for 16 h

at 575 °C in a 5 mL borosilicate ampule with 0.1 mmol sulfur and no HfH_2 . The white dotted box is the region on which FIB was used to create a thin lamella of material for STEM-EDX analysis. It is important to note that this region contains bright, luminescent areas and darker, lower luminescence areas. Fig. 5b is a HAADF-STEM image of the thin lamella that shows gray areas and brighter white areas due to differences in the atomic number of the elements present. STEM-EDX in Fig. 5c–f reveals that the dark area in Fig. 5a, with less luminescence, contains BaZrS_3 , while the areas in Fig. 5a that show strong luminescence in the visible range (1.72 eV) are calcium sulfide. Calcium sulfide is usually a high, indirect band gap material, but studies have shown that when doped with certain elements, it can show strong luminescence at lower energies.^{75–77} We believe this calcium is diffusing from the EXG glass substrate and nucleating around particles of BaZrS_3 , forming luminescent CaS crystals at temperatures of 575 °C after long sulfurization times. As shown in Fig. 5g, these CaS grains show a strong PL emission at 1.72 eV, which is near the expected band gap of

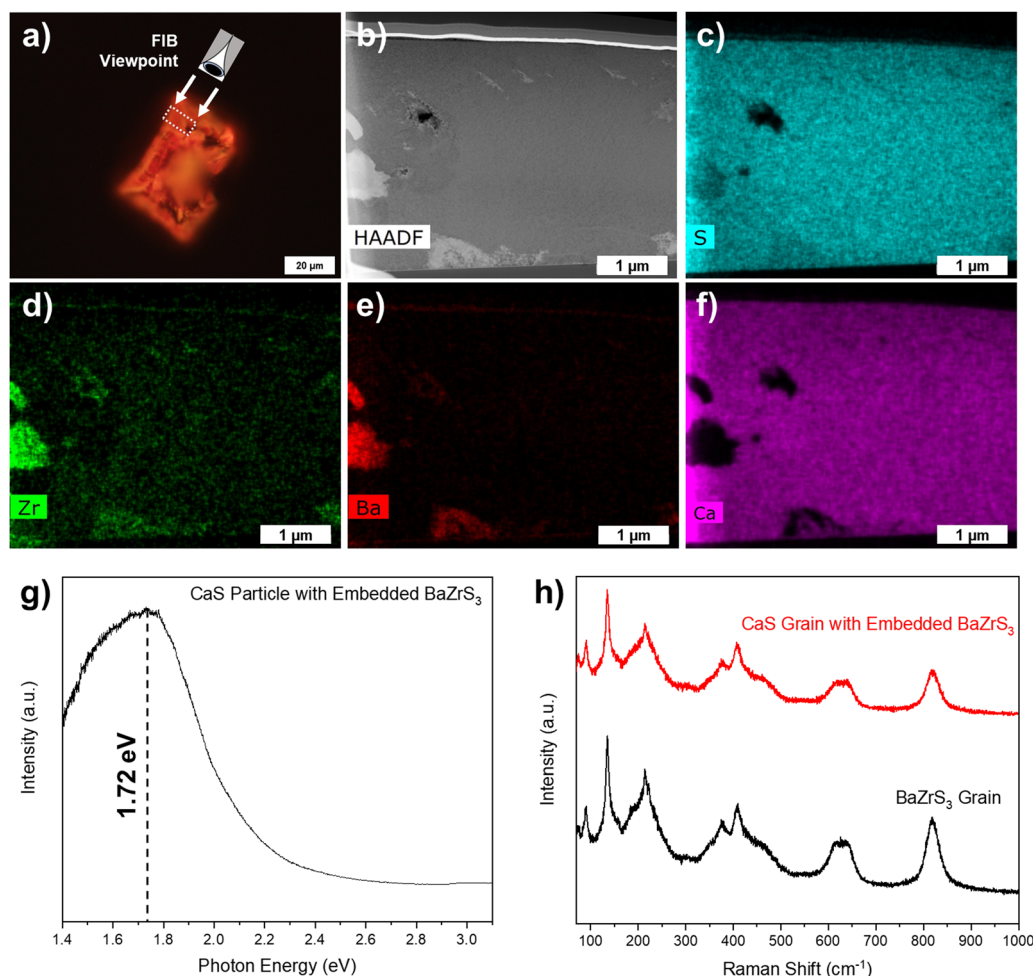


Fig. 5 (a) PL image of a CaS grain with embedded BaZrS_3 . The white dotted box indicates where FIB was performed to create a thin lamella of material for STEM-EDX analysis. (b) A HAADF-STEM image of the lamella where the light grey regions correspond to the darker area in the PL image and the dark grey region corresponds to the luminescent area in the PL image. (c)–(f) EDX maps of the HAADF image indicate that the light grey areas are BaZrS_3 while the dark grey areas are CaS. (g) PL spectrum of the luminescent CaS particle showing an emission centered at 1.72 eV. (h) Raman spectra of the CaS grain with embedded BaZrS_3 compared with that of the BaZrS_3 grain.



BaZrS₃. Initially, these luminescent grains were believed to be BaZrS₃ through Raman analysis. As CaS is not strongly Raman active due to the symmetry of its rock salt structure,⁷⁸ collecting Raman on the CaS grains, as shown in Fig. 5h, resulted in a collection of only the Raman signal from the embedded BaZrS₃. CaS was also not detectable in Raman using a higher energy 532 nm excitation laser. As shown in Fig. S20 (ESI†), grains in Ba–Hf–S films synthesized from Method 5 that showed luminescence near the expected band gap of BaHfS₃ were also found to be CaS with Ba–Hf–S embedded within the grain. Similar to Fig. 5a, Fig. S20 (ESI†) demonstrates that the luminescent areas in the grain correspond to CaS, while the darker regions contained Ba–Hf–S.

Cationic diffusion from glass substrates is a well-established phenomenon in the photovoltaic industry. Specifically, soda-lime glass (SLG) is often used as substrates for Cu(In,Ga)Se₂ (CIGSe) solar cells to incorporate Na intentionally. At temperatures between 500 °C and 600 °C, which is in the same range as SLG's strain point (514 °C), annealing point (550 °C), and glass transition temperature (570 °C), Na ions become more mobile and can diffuse from the glass substrate into the absorber layer, resulting in improved electronic properties in CIGSe.⁷⁹ We also observed that under our sulfurization heat treatment conditions, Na ions diffuse from SLG into the absorber material and form a Na₂ZrS₃ secondary phase within 3 h, as shown in Fig. S21 (ESI†). For this reason, we investigated alternative substrates. While the strain and annealing point of the EXG glass (669 °C and 722 °C respectively) are significantly higher than that of SLG, at temperatures of 575 °C in a sulfur atmosphere, Ca may be diffusing from the substrate and nucleating around crystalline chalcogenide perovskite after several hours. Fig. S22 (ESI†) provides some evidence for Ca diffusion from the glass as SEM-EDX demonstrates that the ratio of Ca to Si in the EXG glass drops by 56% after exposing the glass substrate to a sulfur atmosphere at 575 °C for 10 days.

Although the band gap of CaS is known to be indirect at 4.43 eV,⁸⁰ we found that CaS was responsible for photoemission at 1.72 eV in Ba–Zr–S films and at 2.05 eV in Ba–Hf–S films. Previous literature demonstrates that CaS can act as a host material for phosphors that can be activated by doping from transition metals such as Zr.^{75–77} For CaS:Zr phosphors, the phosphorescence emission band is reported to peak near 605 nm (2.05 eV).⁷⁷ This emission can shift depending on doping concentration, with higher doping concentrations resulting in lower energy emissions.⁷⁷ While CaS:Hf phosphors have not been reported, we believe they are the cause of the emissions we observe at 2.05 eV in the Ba–Hf–S films. BaS has also been shown to act as a host material for phosphors, so caution must also be taken to ensure PL in barium-based chalcogenide perovskites do not originate from BaS phosphors.⁷⁵ Considering the preceding discussion, it is probable that the photoluminescence documented by our group in earlier publications also emanated from CaS with Ba–Zr–S integrated within the grains. This revelation points to a need to reevaluate previous reports of PL emission in low-temperature chalcogenide perovskites.^{50–52}

Quartz substrates were initially considered an excellent alternative to EXG glass as diffusion of cations, such as Ca, from the glass would not be an issue. However, as depicted in Fig. S23 (ESI†), we found that barium can diffuse into the quartz through lattice diffusion under our heat treatment conditions, changing Ba/Zr ratios in the absorber layer. This film, which was synthesized as described in Method 4, does involve a 12 h heat treatment step at 700 °C to form crystalline BaZrO₃ before this material is sulfurized at 575 °C for 24 h to form BaZrS₃. This barium diffusion may be occurring during either (or both) of these heat treatment steps.

A sapphire substrate could be used instead of low-alkali EXG or quartz to minimize diffusion into and out of the substrate. A cheaper alternative would be to deposit an impermeable layer of graphite or a stable oxide material that will not react with sulfur at elevated temperatures, such as alumina, on the quartz substrate before layering with the chalcogenide perovskite to prevent Ba diffusion into the substrate. Furthermore, as BaS and CaS tend not to be strongly Raman active, they can be challenging to detect in small quantities. As both materials can act as phosphors in the presence of transition metals such as Zr or Hf, it is essential to ensure that any photoemission in experimentally synthesized chalcogenide perovskites is coming from the perovskite material instead of secondary phases.

Conclusion

Recent research has demonstrated the successful synthesis of chalcogenide perovskites through solution-based methods at temperatures below 600 °C. Despite significant advancements, several challenges require attention to sustain rapid progress. These challenges include the need for soluble molecular precursors capable of reacting to form chalcogenide perovskites without relying on an external sulfur atmosphere while maintaining a consistent Ba/Zr ratio. Additionally, addressing the elimination of trace amounts of oxygen from both the ampule and the film and carefully managing various sulfur source partial pressures throughout the heat treatment process is crucial. Inadequate sulfur atmospheres can result in the formation of binary BaS or Ruddlesden–Popper phases. Attempts to utilize this phenomenon to produce phase-pure RP phases at low temperatures have proved unsuccessful due to the comparable formation energies of the distorted perovskite and RP phase materials, leading to mixed-phase Ba–Zr–S films.

Utilizing a barium polysulfide flux for moderate-temperature synthesis holds promise for advancing research on chalcogenide perovskites. However, the rapid growth of BaZrS₃ and BaHfS₃ presents several challenges. Firstly, this rapid growth leads to the entrapment of oxide contaminants within large multi-micron-sized grains. Under sulfurization heat treatment conditions, sulfur/H₂S cannot diffuse and react with these oxide contaminants. Additionally, the rapid grain growth results in numerous planar defects within the grains, which persist even after extended annealing at 575 °C. Furthermore, this substantial grain growth produces large cubic grains on the order of tens



of microns per side, hindering the formation of continuous, single-micron absorber layers necessary for synthesizing photovoltaic devices. The electronic defects in this material, as indicated by mid-band gap photoemissions, may also stem from this rapid grain growth or possibly from nano-domains of Ruddlesden–Popper phases present in the film. Enhancing the nucleation rate followed by controlled grain growth could enable the formation of a continuous film of chalcogenide perovskite with grains on the order of hundreds of nanometers, fewer entrapped secondary phases, and improved optoelectronic properties.

Furthermore, given the temperatures employed for sulfurization heat treatment, careful substrate selection is imperative during the solution-deposited synthesis of chalcogenide perovskites. To mitigate sodium diffusion from SLG substrates, we opted for low-alkali Corning EXG glass. However, we observed calcium diffusion from the EXG substrate with extended sulfurization heat treatment durations, leading to nucleation around chalcogenide perovskite crystals. This resulted in the formation of Zr and Hf-doped CaS phosphors, exhibiting photoemissions near the anticipated band gaps of BaZrS₃ and BaHfS₃ in Ba–Zr–S and Ba–Hf–S films. Moreover, as CaS lacks Raman activity, only the underlying chalcogenide perovskites were detectable during Raman analysis, and the abundance of CaS in the films was insufficient to be detected *via* XRD. Hence, meticulous characterization is essential to ensure the absence of difficult-to-detect secondary phases in synthesized films. Although quartz was initially considered a viable alternative to EXG as a substrate, we discovered that Ba diffusion into the quartz occurred under our heat treatment conditions, altering Ba/Zr ratios at the glass interface. Consequently, we advocate using quartz coated with graphite or an inert oxide layer, such as Al₂O₃ to prevent material diffusion into or out of the substrate.

Finally, many of these experiments were only feasible with the meticulous attention to ensuring oxygen- and water-free syntheses. Group IV transition metals, including Zr and Hf, rank among the most oxyphilic metals on the periodic table, rendering their conversion to chalcogenides exceptionally challenging and laborious. While we took the utmost care to conduct all methods described herein in an oxygen- and water-free environment, several steps were carried out using conventional equipment in our laboratory, such as our ampule sealing, which, until now, has been accomplished using a standard glass Schlenk line. This setup features numerous O-ring connections secured by stainless-steel pinch clamps, each representing a potential site for leaks. Given the delicate nature of this material system, these factors and their potential to influence experimental outcomes must be taken into account.

For the chalcogenide perovskite research community to advance BaZrS₃ synthesis for optoelectronic applications, it is crucial to further investigate the following summarized challenges:

1. Solubility of metal precursors (for those taking a solution-based approach).
2. Nucleation of ternary phases.
3. Loss of Ba or Zr during annealing.
4. Sensitivity to sulfur partial pressure.
5. Sensitivity to oxygen.

6. Potential co-formation of the Ruddlesden–Popper (RP) phase impacting optoelectronic properties.
7. Formation of binary compounds at lower sulfur pressures.
8. Use of excess Ba to form phase-pure BaZrS₃, potentially contaminating the material with trace quantities of BaS_x.
9. Island growth leading to non-contiguous films and rapid growth in BaS_x liquid flux.
10. Lack of photoluminescence near the band-to-band region and presence of midgap photoluminescence at 1.05 eV.
11. Photoluminescence from secondary phases with energy emissions near the band gap of the perovskite, with elements such as Ca diffusing into the film and showing photoluminescence *via* CaS phosphors.

Chalcogenide perovskites remain a compelling alternative to halide perovskites for optoelectronic applications, with their synthesis at temperatures compatible with device fabrication offering additional prospects. However, further refinement of growth conditions and enhancement of optoelectronic properties are prerequisites before integrating these materials into optoelectronic devices.

Experimental section

Chemicals and materials

Bis(pentamethylcyclopentadienyl)barium(II) (Cp*₂Ba, 98%), barium acetate (99%), and zirconium acetylacetonate (97%) were purchased from Strem and used as received. Tetrakis(ethylmethylamino)zirconium(IV) (TEMAZ), >99.99%, Tetrakis(dimethylamino)zirconium(IV) (TDMAZ), >99.99%, tetrakis(ethylmethylamino)hafnium(IV) (TEMAH), >99.99%, barium sulfide (BaS, 99.9%), polyvinyl butyral, propionic acid (ACS Reagent, >99.5%), and carbon disulfide (CS₂, anhydrous, >99%) were purchased from Sigma Aldrich and used as received. Butylamine (BA, >99.5%), Propylamine (PA, >99.0%), and 2-methyl-2-propanethiol (>99%) were purchased from Sigma Aldrich and stored over molecular sieves before use. Pyridine (Pyd, anhydrous, 99.8%) was purchased from Sigma-Aldrich and was further dried by stirring over calcium hydride for 36 h, followed by distillation. The pyridine was stored over molecular sieves and calcium hydride chunks in a nitrogen atmosphere. Sulfur flakes (S, 99.99%) were purchased from Sigma Aldrich, ground into a powder in an inert atmosphere, and dried under vacuum overnight at ambient temperature. Hafnium hydride nanopowder (HfH₂, 99.9%) and Zirconium Hydride (ZrH₂, 99.9%) were purchased from Nano Research Elements and used as received. All chemicals and solvents were handled inside inert nitrogen-filled gloveboxes. Carbon disulfide is a highly flammable and volatile species that is known to cause acute organ and nervous system damage. Only use CS₂ in well-ventilated hoods or glove boxes and keep it away from open flames and hot surfaces.

Low-alkali Eagle XG (EXG) glass (1.1 mm thick) was purchased from Corning and quartz glass (1 mm thick) was purchased from Quartz Scientific, cleaned with IPA, hexane, Alconox, ultrapure water, and acetone, and dried on a hotplate at annealing temperatures for 5 minutes immediately before



use. 5 mL borosilicate glass ampules were purchased from Chemglass, cleaned with IPA, hexane, and acetone, and dried at 150 °C for at least 30 minutes immediately before use. The SEM-EDX confirmed the following elements in the EXG glass: Si, O, Al, Ca, and Mg.

Method 1: synthesis of Ba–Zr–S films using BaS and TEMAZ.

While BaS is insoluble in nearly all commonly used solvent systems we tested, we did find one successful dissolution system. Thus, in a 4 mL vial under an inert nitrogen atmosphere, 1 mmol propylamine was combined with 1 mmol CS₂, 0.1 mmol BaS, and 715 μL Pyd to create a 0.2 M solution. After stirring for 24 h at 35 °C, 0.1 mmol of TEMAZ was added to the solution and stirred for 6 h at 35 °C before use. The ink was blade coated on a 1-inch by 2-inch EXG substrate with 15 μL deposited per layer for six layers. Between each layer, the film was annealed at 275 °C on a hotplate under an inert nitrogen atmosphere for 90 s per layer to evaporate away solvents and partially decompose the molecular precursors in the ink. The film was then cut into 1-inch by ¼-inch strips before undergoing sulfurization heat treatment in ampules.

Method 2: synthesis of Ba–Zr–S films using Cp*₂Ba and ZrH₂. A mixed hybrid precursor ink was prepared by co-dissolving 0.1 mmol each of Cp*₂Ba and ZrH₂ nanoparticle powder in 200 μL butylamine and 113 μL 2-methyl-2-propanethiol (except for sample 10 as mentioned in Table 2). 50 μL ink was drop cast on a 1-inch by 0.25-inch EXG substrate and annealed on the hotplate at 100 °C for 4 minutes and 400 °C for 25 minutes to evaporate away solvents and partially decompose the molecular precursors in ink. The film then underwent sulfurization heat treatment in ampules. A similar procedure was used for Ba–Hf–S films.

Method 3: synthesis of Ba–Zr–S films using Cp*₂Ba and TDMAZ. These Ba–Zr–S films were synthesized using the method reported earlier by our group, whereby a precursor suspension was created by combining Cp*₂Ba and tetrakis(dimethylamino)-zirconium(IV) (TDMAZ) in a 1.4 to 1 molar ratio in CS₂ to create an ink with a concentration of 0.023 M Ba and 0.017 M Zr.⁵⁷ As described in previous work using this precursor, the excess Ba was required to create a crystalline ternary material after sulfurization.⁵⁷ The resulting species only partially dissolved in CS₂, creating a dark orange suspension. The suspension was heated to 100 °C in a solvothermal microwave reactor for 1 h, during which the internal pressure of the microwave vial reached 3 bar. After microwaving, an additional 1 mL of CS₂ was used to quantitatively transfer all material out of the microwave vial, resulting in a final ink suspension concentration of 0.0175 M Ba and 0.0125 M Zr.

Next, 120 μL of the ink was dropcast onto an EXG substrate and allowed to dry at 50 °C. The glass substrate was then transferred to a hotplate at 300 °C and allowed to anneal for 5 min to decompose the metal complexes and leave behind an amorphous Ba–Zr–S material.

Method 4: synthesis of BaZrO₃ Films. BaZrO₃ was synthesized as described by Gupta *et al.* and as reported in Agarwal *et al.* using an ink containing 0.3 M barium acetate and 0.3 M zirconium acetylacetonate in a propionic acid solvent.^{4,65}

Then, 0.5 g of polyvinyl butyral was added per 15 mL of solution and heated to 60 °C for 1 h until dissolved. The ink was spin-coated in the air at 2000 rpm for 1 min, followed by 5000 RPM for 5 min. The film was then annealed on a hot plate at 500 °C for 5 min in air. This procedure was repeated nine additional times to increase the thickness of the deposited film. The film was then heated in a refractory tube furnace at 700 °C for 12 h under air to produce crystalline BaZrO₃.

Method 5: synthesis of Ba–Hf–S films using Cp*₂Ba and TDMAH. In a vial in an inert nitrogen atmosphere, 0.14 mmol Cp*₂Ba and 0.1 mmol TDMAH were combined. Then 0.8 mL CS₂ was added dropwise to the vial. The solution was allowed to stir at ambient temperature for 24 h. Excess CS₂ was then removed using a convective flow of argon. Next, 600 μL of anhydrous Pyd was added to redissolve the complexes, creating a fully dissolved ink. This ink was filtered using a 0.4 μm PTFE syringe filter to remove undissolved material before being blade-coated on a 1-inch by 2-inch EXG substrate. 20 μL of ink was used per layer for six layers. Between each layer, the film was annealed at 275 °C for 1 minute to evaporate away the solvent and decompose the molecular precursor. The film was then cut into 1-inch by ¼-inch strips for sulfurization heat treatment.

Sulfurization heat treatment

Without any exposure to air, Ba–Zr–S, Ba–Hf–S, or BaZrO₃ films were cut into 25 mm by 7 mm strips in a glovebox (except for the films from Method 2 which were already pre-cut) and placed in 5 mL borosilicate glass ampules. A borosilicate glass NMR tube was cut to roughly two inches, and various amounts of sulfur and HfH₂ were carefully weighed into it, as described in the main text (no HfH₂ was used for samples from Method 2). Quartz wool was then placed into the tubes so that the solid powders could not escape from the NMR tube, but vapor phase sulfur and H₂S could escape. This NMR tube was placed in the ampule alongside the film. The ampule was sealed using a butane torch at a pressure below 200 mtorr.

The sealed ampule was placed in a refractory tube furnace and heated to 575 °C at a ramp rate of roughly 1 °C s^{−1}. Once the setpoint temperature was reached, the ampule was held at the setpoint temperature. The furnace was cooled through forced convection at roughly 14 °C min^{−1}. Samples were kept in sealed ampules until they were ready for analysis.

Characterization

X-ray diffraction (XRD) was performed with a Rigaku SmartLab diffractometer utilizing a Cu-Kα (λ = 1.5406 Å) source operated at 40 kV/44 mA in parallel beam mode at an incident angle of 0.5°. Raman spectroscopy was performed using a Horiba/Jobin-Yvon LabRAM HR800 confocal microscope setup through a 50× objective lens using a He:Ne laser (632.8 nm excitation wavelength). A Fischerscope X-Ray XAN 250 was used to collect X-ray fluorescence (XRF) elemental composition data.

Photoluminescence (PL) measurements in the range of 1.38 to 3.10 eV and PL imaging were captured using an X-Cite Series 120 Q lamp as an excitation source. An Olympus BX53 microscope with a 330–385 nm bandpass filter for excitation and a



dichroic mirror with a 400 nm cutoff wavelength was used for PL spectra measurement, and these PL spectra used a Spectra-Pro HRS-300 spectrometer using a silicon detector. For PL measurements in the range of 0.9 to 1.8 eV, a Horiba/Jobin-Yvon LabRAM HR800 confocal microscope set up through a 50× objective lens using a He:Ne laser (632.8 nm excitation wavelength) using an InGaAs detector. Transfer functions for both PL systems were acquired by utilizing a calibrated halogen light source to correct for optical losses due to the internal optics of the microscopes and account for changes in detector quantum efficiencies. PL measurements with 447 nm, 520 nm, 550 nm, and 600 nm lasers were performed using a home-built confocal micro-photoluminescence setup. Time-resolved photoluminescence measurements were carried out using a 637 nm diode laser (100 kHz to 1 MHz) and an InGaAs photomultiplier tube (Hamamatsu H10330A-45) under low-level injection conditions.

Scanning electron microscopy (SEM) and energy dispersive X-ray (EDX) analyses were conducted using a Quanta 3D FEG with an accelerating voltage of 10 kV, a spot size of 1.0, and a working distance of 10 mm. Transmission electron microscope (TEM) samples were prepared using a Ga-focused ion beam (FIB) on an FEI HELIOS 600 Dual Beam FIB-SEM, and TEM, HAADF, and EDX imaging was performed on an FEI Talos F200X scanning/transmission electron microscope (STEM).

Author contributions

Apurva A. Pradhan and Shubhanshu Agarwal: conceptualization, investigation, data curation, validation, formal analysis, visualization, writing – original draft, writing – review & editing. Kiruba Catherine Vincent: data curation, validation, formal analysis, writing – review & editing, visualization. Daniel C. Hayes: Data curation, formal analysis, writing – review & editing. Jonas M. Peterson: data curation, formal analysis. Jonathan W. Turnley: conceptualization, writing – review & editing. Robert M. Spilker: data curation. Madeleine C. Uible: data curation. Suzanne C. Bart: resources. Libai Huang: resources. Kim Kisslinger: data curation. Rakesh Agrawal: writing – review & editing, resources, supervision, project administration, funding acquisition.

Data availability

The data supporting this article have been included in the ESI.†

Conflicts of interest

The authors do not have any conflict of interest to declare regarding the work published in this article.

Acknowledgements

This work was supported by the Research Traineeship Program (No. 1735282-NRT (SFEWS) and 10001536 (INFEWS)). This

research used Electron Microscopy facilities of the Center for Functional Nanomaterials (CFN), a U.S. Department of Energy Office of Science User Facility, at Brookhaven National Laboratory under Contract No. DE-SC0012704.

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